

Specifications

Drawing No.	UKY1C-H2-25AAA-00[43] 1/10
Issued Date.	2025/08/29

TO:

Note: Part numbers may be revised in the event of any specifications change.

Not applicable for
military, automotive,
implantable medical
use, and applications
which may cause
loss of life or assets.

Product Name	Quartz Crystal
Product Model	CX3225SB
Frequency	20000 kHz
Customer Part Number	-
Customer Specification Number	-
KYOCERA Part Number	CX3225SB20000D0GLLCC
Remarks	Pb-Free, RoHS Compliant, MSL 1

Customer Acceptance

Accept Signature	Approved Date	
	Department	
	Person in charge	

Seller
KYOCERA Corporation

Corporate Electronic Components Group
Electronic Components Sales Division

6 Takeda Tobadono-cho, Fushimi-ku, Kyoto
612-8501 Japan
TEL. No. 075-604-3500
FAX. No. 075-604-3501

Manufacturer

Corporate Electronic Components Group
Electronic Devices Division

Design Department	Quality Assurance	Approved by	Checked by	Checked by	Issued by
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KYOCERA Corporation

KYOCERA Corporation Crystal Components Application Engineering Section 2 Electronic Devices Division Corporate Electronic Components Group	-	-	-	-	-
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Revision History

Rev.No.	Description of revise	Date	Approved by	Checked by	Issued by
00	First Edition	2025/08/29	-	-	-

1. APPLICATION

This specification sheet is applied to quartz crystal "CX3225SB20000D0GLLCC"

2. KYOCERA PART NUMBER

CX3225SB20000D0GLLCC

3. RATINGS

Items	SYMB.	Rating	Unit	Remarks
Operating Temperature	Topr	-30 to +85	°C	
Storage Temperature range	Tstg	-40 to +85	°C	

4. CHARACTERISTICS

ELECTRICAL CHARACTERISTICS

Items	Electrical Specification					Test Condition	Remarks
	SYMB.	Min	Typ.	Max	Unit		
Mode of Vibration		Fundamental					
Nominal Frequency	F0		20		MHz		
Nominal Temperature	T _{NOM}		+25		°C		
Load Capacitance	CL	8			pF		
Frequency Tolerance	df/F	-15		+15	PPM	+25±3°C	by Measurement Conditions
Frequency Temperature characteristics	df/F	-20		+20		-30 to +85 °C	Based on an oscillation frequency at + 25 °C
Frequency Aging Rate		-1.0		+1.0		1 st year	+25±3°C
Equivalent Series Resistance	ESR			50	Ω		by Measurement Conditions
Drive Level	Pd	0.01		100	μW		
Insulation Resistance	IR	500			MΩ	100V (DC)	

5. Measurement Condition

5.1 Frequency measurement

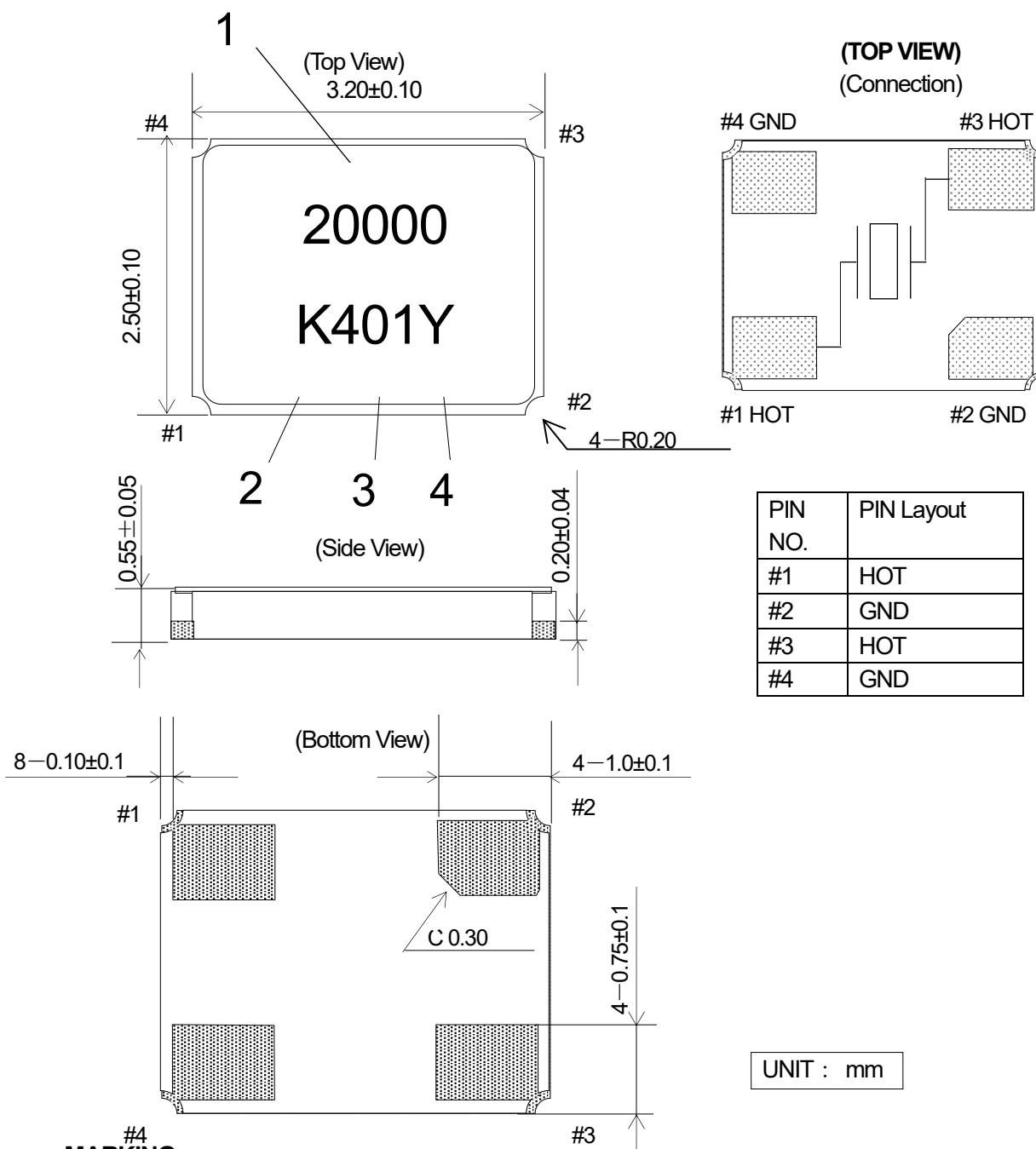
Measuring instrument : IEC PI-Network Test Fixture
 Load Capacitance : 8pF
 Drive Level : 10μW

5.2 Equivalent series resistance (ESR) measurement

Measuring instrument : IEC PI-Network Test Fixture
 Load Capacitance : Series
 Drive Level : 10μW

6. APPEARANCES, PHYSICAL DIMENSION

OUTLINE DIMENSION (not to scale)

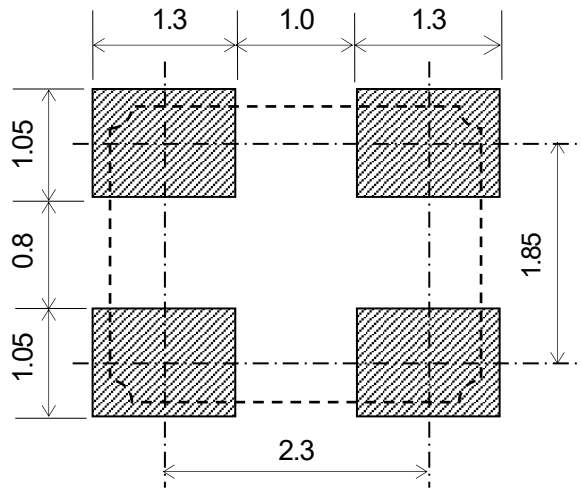


MARKING

- Nominal Frequency Move the number of maximum indication beams of the frequency to five digits, and omit less than kHz.
- Identification [K] mark is surely 1Pin direction.
- Date Code Year...LAST 1 DIGIT of YEAR AND WEEK
(Ex)Jan, 01, 2024 → 401
- Manufacturing Location
Y...Japan (Yamagata)
Z...Japan (Shiga Yohkaichi)

※The font of marking is reference.

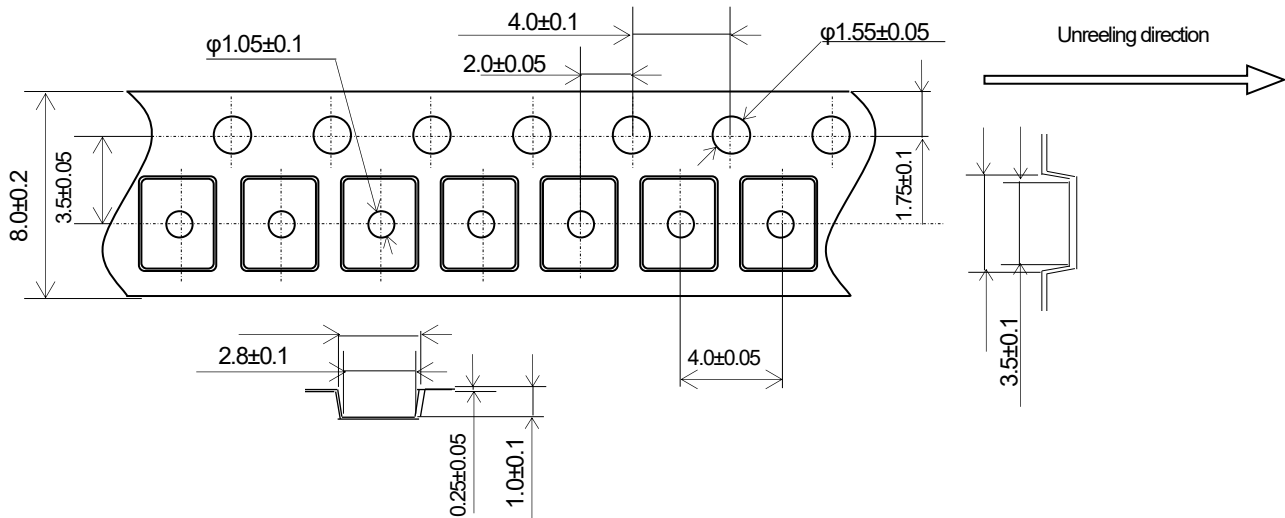
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7. RECOMMENDED LAND PATTERN (not to scale)

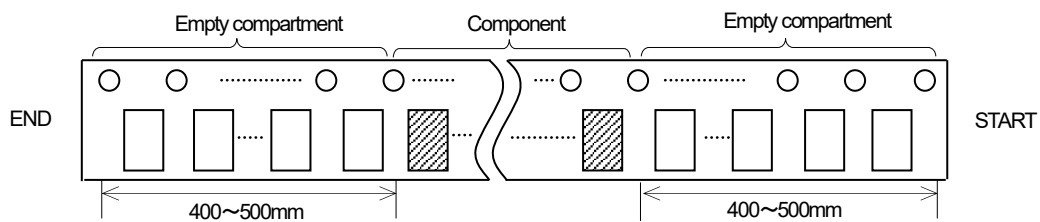
UNIT : mm

8.TAPING & REEL

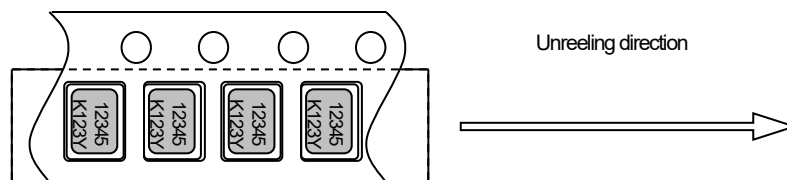
8-1.Dimensions



8-2.Leader and trailer tape

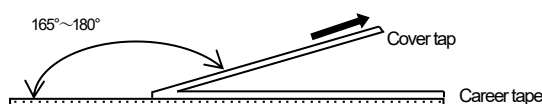


8-3.Direction (The direction shall be seen from the top cover tape side)

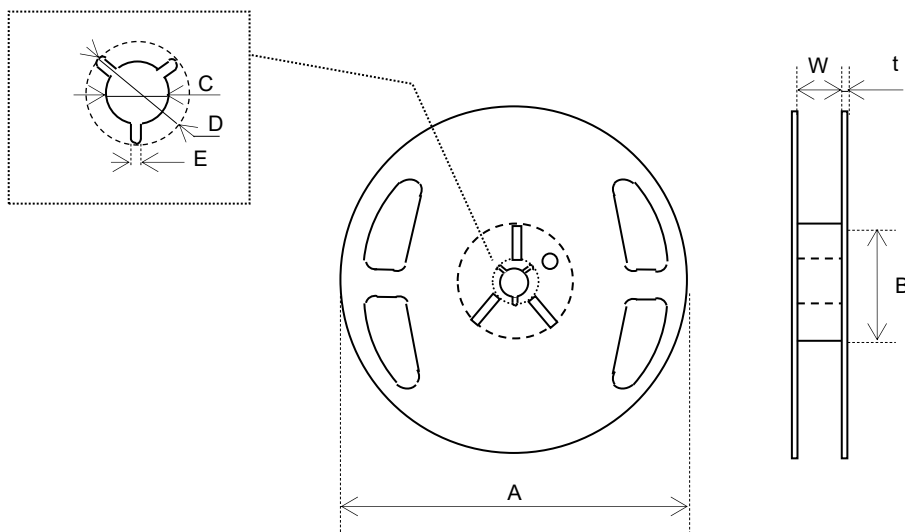


8-4.Specification

1. Material of the carrier tape is either polystyrene or A—PET (ESD).
2. Material of the cover tape is PET/PE (ESD).
3. The seal tape shall not cover the sprocket holes and not protrude from the carrier tape.
4. Tensile strength of carrier tape: 10N or more.
5. The R of the corner of each cavity is 0.2RMAX.
6. The alignment between centers of the cavity and sprocket hole shall be 0.05mm or less.
7. The orientation shall be checked from the top cover tape side as shown in 8-3.
8. Peeling force of cover tape: 0.1 to 1.0N.
9. The component will fall out naturally when cover tape is removed and set upside down.



8-5.Reel Specification



In the case of $\Phi 180$ Reel (3,000 pcs max, every 1,000 pcs)

Symbol	A	B	C	D
Dimension	$\phi 180 +0/-3$	$\phi 60 +1/-0$	$\phi 13 \pm 0.2$	$\phi 21 \pm 0.8$
Symbol	E	W	t	
Dimension	2.0 ± 0.5	9 ± 1	2.0 ± 0.5	

(Unit : mm)

In the case of $\Phi 330$ Reel (10,000 pcs max, every 1,000 pcs)

Symbol	A	B	C	D
Dimension	$\phi 330 \pm 2.0$	$\phi 100 \pm 1.0$	$\phi 13 \pm 0.2$	$\phi 21 \pm 0.8$
Symbol	E	W	t	
Dimension	2.0 ± 0.5	9.5 ± 0.5	2.2 ± 0.1	

(Unit : mm)

9. Environmental requirements

After following test, frequency shall not change more than $\pm 10 \times 10^{-6}$

And CI, $\pm 20\%$ or 5Ω of large value.

- | | |
|-----------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 9.1 Resistance to Shock | <p>Test condition</p> <p>Natural dropped from height 100cm onto hard wood board in 3 times</p> |
| 9.2 Resistance to Vibration | <p>Test condition</p> <p>frequency : 10 - 55 - 10 Hz</p> <p>Amplitude : 1.5mm</p> <p>Cycle time : 15 minutes</p> <p>Direction : X,Y,Z (3direction), 2 h each.</p> |
| 9.3 Resistance to Heat | <p>Test condition</p> <p>The quartz crystal unit shall be stored at a temperature of $+85 \pm 2^\circ\text{C}$ for 500 h.</p> <p>Then it shall be subjected to standard atmospheric conditions for 1 h ,after whichi measurement shall be made.</p> |
| 9.4 Resistance to Cold | <p>Test condition</p> <p>The quartz crystal unit shall be stored at a temperature of $-40 \pm 2^\circ\text{C}$ for 500 h.</p> <p>Then it shall be subjected to standard atmospheric conditions for 1 h ,after whichi measurement shall be made.</p> |
| 9.5 Thermal Shock | <p>Test condition</p> <p>The quartz crystal unit shall be subjected to 500 succesive change of temperature cycles , each as shown in table below, Then it shall be subjected to standard atmospheric conditions for 1h, after which measurements shall be made.</p> <p>Cycle : $-40 \pm 2^\circ\text{C}$ (30min.) to $+25 \pm 2^\circ\text{C}$ (5min.)
to $+85 \pm 2^\circ\text{C}$ (30min.) to $+25 \pm 2^\circ\text{C}$ (5min.)</p> |

9.6 Resistance to Moisture

Test condition

The quartz crystal unit shall be stored at a temperature of $+60\pm 2^{\circ}\text{C}$ with relative humidity of 90% to 95% for 240 h. Then it shall be subjected to standard atmospheric conditions for 1h, after which measurements shall be made

9.7 Soldering condition

1.) Material of solder

Kind ... lead free solder paste

Melting point ... $+220\pm 5^{\circ}\text{C}$

2.) Reflow temp.profile

	Temp [$^{\circ}\text{C}$]	Time[sec]
Preheating	+150 to +180	150 (typ.)
Peak	$+260\pm 5$	10 (max.)
Total	—	300 (max.)

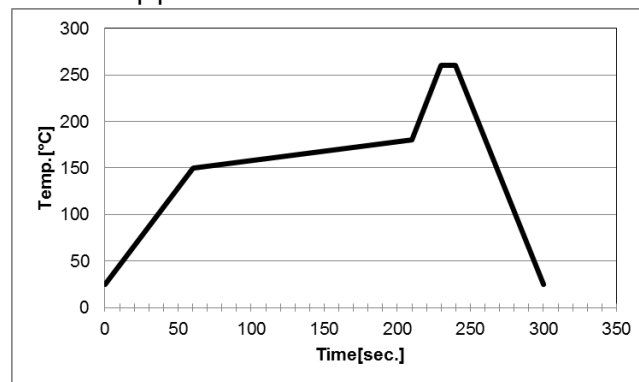
3.) Hand Soldering

$+350^{\circ}\text{C}$ 3 sec MAX

4.) Reflow Times

2 times

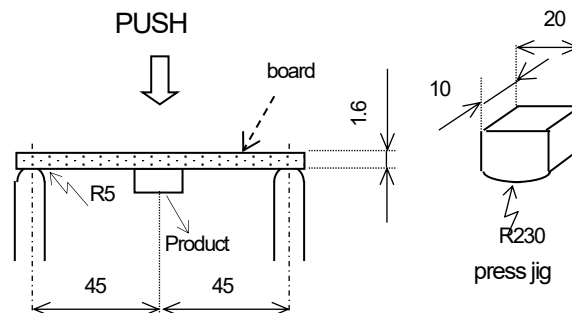
Reflow temp.profile



9.8 Intensity for bending in circuit board

Solder this product in center of the circuit board of $40\text{mm}\times 100\text{mm}$, and add the deflection of 3mm as the bottom figure.

Test board : $t=1.6\text{mm}$



UNIT : mm

10. Cautions for use

(1)Soldering upon mounting

There is a possibility to influence product characteristics when Solder paste or conductive glue comes in contact with product lid or surface.

(2)When using mounting machine

Please minimize the shock when using mounting machine to avoid any excess stress to the product.

(3)Conformity of a circuit

We strongly recommend to make sure that Negative resistance (Gain) of IC is designed to be 5 times the ESR (Equivalent Series Resistance) of crystal unit.

11. Storage conditions

Please store product in below conditions, and use within 6 months.

Temperature +18 to +30°C, and Humidity of 20 to 70 % in the packaging condition.

12. Manufacturing location

Kyocera Corporation Yamagata Higashine Plant / Japan (Yamagata)

Kyocera Corporation Shiga Yohkaichi Plant / Japan (Shiga)

13. Quality Assurance

To be guaranteed by Kyocera Corporation Yamagata Higashine Plant Quality Assurance Division

14. Quality guarantee

In case when Kyocera Corporation rooted failure occurred within 1year after its delivery, substitute product will be arranged based on discussion. Quality guarantee of product after 1year of its delivery is waived.

15. Others

In case of any questions or opinions regarding the Specification, please have it in written manner within 45 days after issued date.